

Notice of References Cited

Application/Control No.

10/053,085

Applicant(s)/Patent Under

Reexamination

GORTE ET-AL.

Examiner

Dah-Wei D. Yuan

Art-Unit

1745

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,228,033	10-1980	Yamauchi et al.	502/26
	B	US-6,017,647	01-2000	Wallin, Sten A.	429/33
	C	US-6,051,330	04-2000	Fasano et al.	429/30
	D	US-6,221,280	04-2001	Anumakonda et al.	252/372
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.